

# RF Power Field Effect Transistor

## N-Channel Enhancement-Mode Lateral MOSFET

Designed for base station applications with frequencies from 618 to 803 MHz. Can be used in Class AB and Class C for all typical cellular base station modulation formats.

- Typical Single-Carrier W-CDMA Performance:  $V_{DD} = 28$  Volts,  $I_{DQ} = 1200$  mA,  $P_{out} = 50$  Watts Avg., IQ Magnitude Clipping, Channel Bandwidth = 3.84 MHz, Input Signal PAR = 7.5 dB @ 0.01% Probability on CCDF.

Frequency (1)	$G_{ps}$ (dB)	$\eta_D$ (%)	Output PAR (dB)	ACPR (dBc)
728 MHz	19.7	37.1	6.2	-38.7
748 MHz	19.5	37.0	6.1	-37.5
768 MHz	19.4	37.9	6.1	-37.8

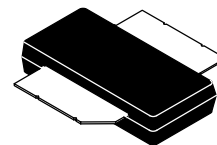
- Capable of Handling 10:1 VSWR, @ 32 Vdc, 748 MHz, 170 Watts CW Output Power (3 dB Input Overdrive from Rated  $P_{out}$ ), Designed for Enhanced Ruggedness
- Typical  $P_{out}$  @ 1 dB Compression Point  $\approx 182$  Watts CW

### Features

- 100% PAR Tested for Guaranteed Output Power Capability
- Characterized with Series Equivalent Large-Signal Impedance Parameters and Common Source S-Parameters
- Internally Matched for Ease of Use
- Integrated ESD Protection
- Greater Negative Gate-Source Voltage Range for Improved Class C Operation
- Designed for Digital Predistortion Error Correction Systems
- 225°C Capable Plastic Package
- In Tape and Reel. R3 Suffix = 250 Units per 32 mm, 13-inch Reel.

**MRF8S7170NR3**

**618-803 MHz, 50 W AVG., 28 V  
SINGLE W-CDMA  
LATERAL N-CHANNEL  
RF POWER MOSFET**



**OM-780-2L  
PLASTIC**

**Table 1. Maximum Ratings**

Rating	Symbol	Value	Unit
Drain-Source Voltage	$V_{DSS}$	-0.5, +70	Vdc
Gate-Source Voltage	$V_{GS}$	-6.0, +10	Vdc
Operating Voltage	$V_{DD}$	32, +0	Vdc
Storage Temperature Range	$T_{stg}$	-65 to +150	°C
Case Operating Temperature	$T_C$	150	°C
Operating Junction Temperature (2,3)	$T_J$	225	°C

**Table 2. Thermal Characteristics**

Characteristic	Symbol	Value (3,4)	Unit
Thermal Resistance, Junction to Case Case Temperature 80°C, 170 W CW, 28 Vdc, $I_{DQ} = 1200$ mA Case Temperature 81°C, 50 W CW, 28 Vdc, $I_{DQ} = 1200$ mA	$R_{\theta JC}$	0.30 0.37	°C/W

- This part is not recommended for Doherty applications across the 600 to 728 MHz band.
- Continuous use at maximum temperature will affect MTTF.
- MTTF calculator available at <http://www.freescale.com/rf>. Select Software & Tools/Development Tools/Calculators to access MTTF calculators by product.
- Refer to AN1955, *Thermal Measurement Methodology of RF Power Amplifiers*. Go to <http://www.freescale.com/rf>. Select Documentation/Application Notes - AN1955.

**Table 3. ESD Protection Characteristics**

Test Methodology	Class
Human Body Model (per JESD22-A114)	2
Machine Model (per EIA/JESD22-A115)	A
Charge Device Model (per JESD22-C101)	IV

**Table 4. Moisture Sensitivity Level**

Test Methodology	Rating	Package Peak Temperature	Unit
Per JESD22-A113, IPC/JEDEC J-STD-020	3	260	°C

**Table 5. Electrical Characteristics** ( $T_A = 25^\circ\text{C}$  unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
----------------	--------	-----	-----	-----	------

**Off Characteristics**

Zero Gate Voltage Drain Leakage Current ( $V_{DS} = 70\text{ Vdc}$ , $V_{GS} = 0\text{ Vdc}$ )	$I_{DSS}$	—	—	10	$\mu\text{Adc}$
Zero Gate Voltage Drain Leakage Current ( $V_{DS} = 28\text{ Vdc}$ , $V_{GS} = 0\text{ Vdc}$ )	$I_{DSS}$	—	—	1	$\mu\text{Adc}$
Gate-Source Leakage Current ( $V_{GS} = 5\text{ Vdc}$ , $V_{DS} = 0\text{ Vdc}$ )	$I_{GSS}$	—	—	1	$\mu\text{Adc}$

**On Characteristics**

Gate Threshold Voltage ( $V_{DS} = 10\text{ Vdc}$ , $I_D = 355\ \mu\text{Adc}$ )	$V_{GS(th)}$	1.5	2.3	3	Vdc
Gate Quiescent Voltage ( $V_{DD} = 28\text{ Vdc}$ , $I_D = 1200\text{ mAdc}$ , Measured in Functional Test)	$V_{GS(Q)}$	2.3	3.1	3.8	Vdc
Drain-Source On-Voltage ( $V_{GS} = 10\text{ Vdc}$ , $I_D = 2.9\text{ Adc}$ )	$V_{DS(on)}$	0.1	0.22	0.3	Vdc

**Functional Tests** <sup>(1)</sup> (In Freescale Test Fixture, 50 ohm system)  $V_{DD} = 28\text{ Vdc}$ ,  $I_{DQ} = 1200\text{ mA}$ ,  $P_{out} = 50\text{ W Avg.}$ ,  $f = 748\text{ MHz}$ , Single-Carrier W-CDMA, IQ Magnitude Clipping, Input Signal PAR = 7.5 dB @ 0.01% Probability on CCDF. ACPR measured in 3.84 MHz Channel Bandwidth @  $\pm 5\text{ MHz}$  Offset.

Power Gain	$G_{ps}$	18.0	19.5	21.0	dB
Drain Efficiency	$\eta_D$	34.0	37.0	—	%
Output Peak-to-Average Ratio @ 0.01% Probability on CCDF	PAR	5.7	6.1	—	dB
Adjacent Channel Power Ratio	ACPR	—	-37.5	-35.0	dBc
Input Return Loss	IRL	—	-24	-9	dB

**Typical Broadband Performance** (In Freescale Test Fixture, 50 ohm system)  $V_{DD} = 28\text{ Vdc}$ ,  $I_{DQ} = 1200\text{ mA}$ ,  $P_{out} = 50\text{ W Avg.}$ , Single-Carrier W-CDMA, IQ Magnitude Clipping, Input Signal PAR = 7.5 dB @ 0.01% Probability on CCDF. ACPR measured in 3.84 MHz Channel Bandwidth @  $\pm 5\text{ MHz}$  Offset.

Frequency	$G_{ps}$ (dB)	$\eta_D$ (%)	Output PAR (dB)	ACPR (dBc)	IRL (dB)
728 MHz	19.7	37.1	6.2	-38.7	-13
748 MHz	19.5	37.0	6.1	-37.5	-24
768 MHz	19.4	37.9	6.1	-37.8	-16

1. Part internally matched both on input and output.

(continued)

**Table 5. Electrical Characteristics** ( $T_A = 25^\circ\text{C}$  unless otherwise noted) (continued)

Characteristic	Symbol	Min	Typ	Max	Unit
<b>Typical Performances</b> (In Freescale Test Fixture, 50 ohm system) $V_{DD} = 28\text{ Vdc}$ , $I_{DQ} = 1200\text{ mA}$ , 618–803 MHz Bandwidth					
$P_{out}$ @ 1 dB Compression Point, CW	$P_{1dB}$	—	182	—	W
IMD Symmetry @ 160 W PEP, $P_{out}$ where IMD Third Order Intermodulation $\cong 30\text{ dBc}$ (Delta IMD Third Order Intermodulation between Upper and Lower Sidebands > 2 dB)	$IMD_{sym}$	—	16	—	MHz
VBW Resonance Point (IMD Third Order Intermodulation Inflection Point)	$VBW_{res}$	—	65	—	MHz
Gain Flatness in 185 MHz Bandwidth @ $P_{out} = 50\text{ W Avg.}$	$G_F$	—	0.5	—	dB
Gain Variation over Temperature ( $-30^\circ\text{C}$ to $+85^\circ\text{C}$ )	$\Delta G$	—	0.017	—	dB/ $^\circ\text{C}$
Output Power Variation over Temperature ( $-30^\circ\text{C}$ to $+85^\circ\text{C}$ )	$\Delta P_{1dB}$	—	0.0048	—	dB/ $^\circ\text{C}$

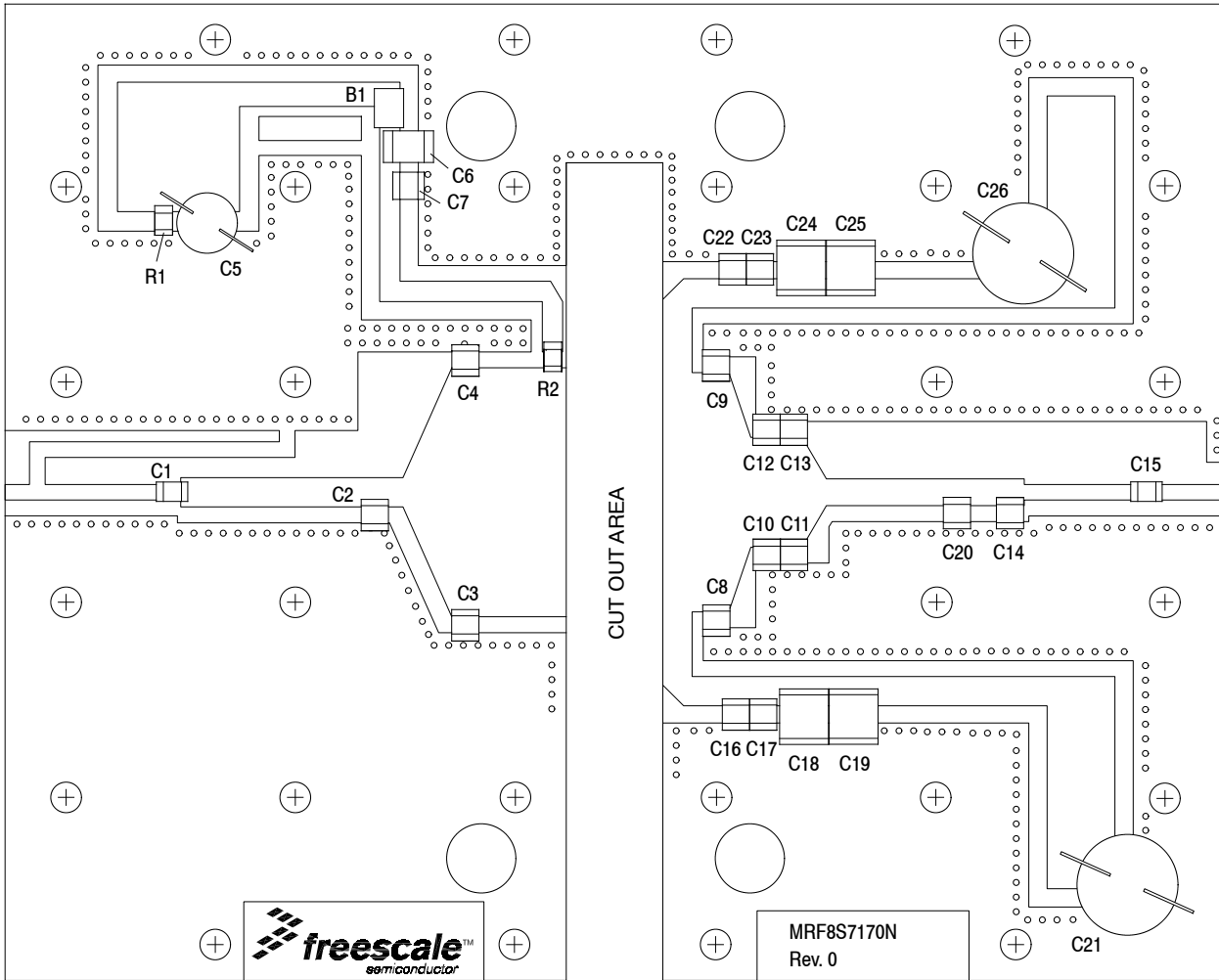
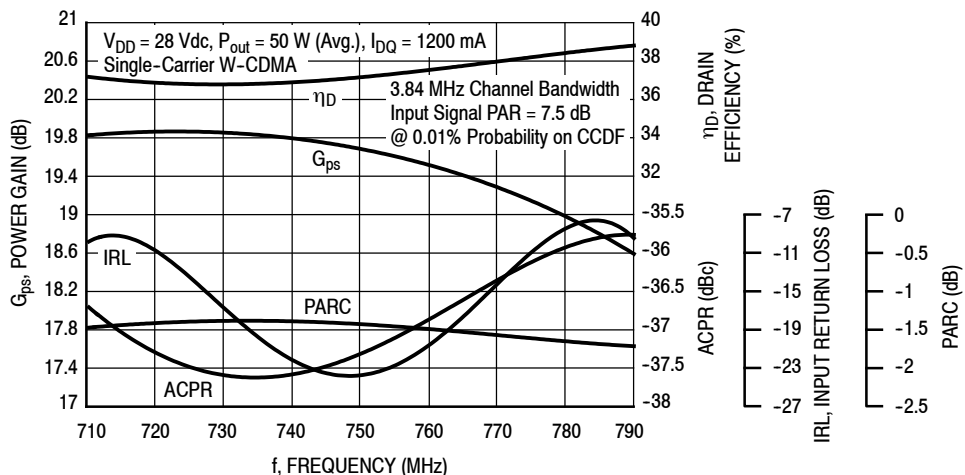


Figure 1. MRF8S7170NR3 Test Circuit Component Layout

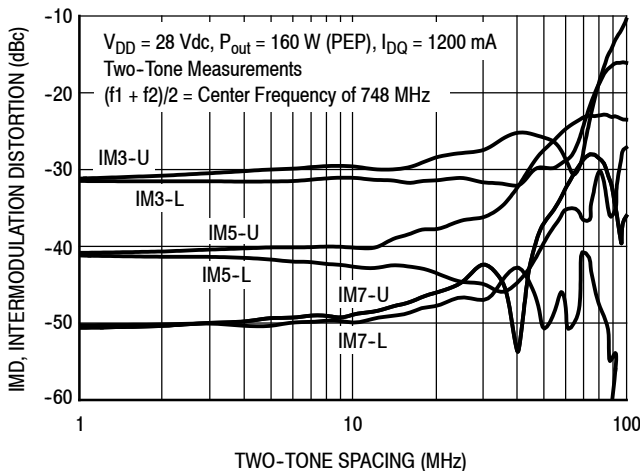
Table 6. MRF8S7170NR3 Test Circuit Component Designations and Values

Part	Description	Part Number	Manufacturer
B1	Ferrite Bead, Short	2743019447	Fair-Rite
C1	2.7 pF Chip Capacitor	ATC100B2R7BT500XT	ATC
C2	2.2 pF Chip Capacitor	ATC100B2R2JT500XT	ATC
C3, C4	9.1 pF Chip Capacitors	ATC100B9R1CT500XT	ATC
C5	47 $\mu$ F, 63 V Electrolytic Capacitor	476KXM063M	Illinois Capacitor
C6	6.8 $\mu$ F, 100 V Chip Capacitor	C4532X7R1H685KT	TDK
C7	100 pF Chip Capacitor	ATC100B101JT500XT	ATC
C8, C9	11 pF Chip Capacitors	ATC100B110JT500XT	ATC
C10, C12	6.8 pF Chip Capacitors	ATC100B6R8CT500XT	ATC
C11, C13	7.5 pF Chip Capacitors	ATC100B7R5CT500XT	ATC
C14	5.1 pF Chip Capacitor	ATC100B5R1CT500XT	ATC
C15, C16, C17, C22, C23	39 pF Chip Capacitors	ATC100B390JT500XT	ATC
C18, C19, C24, C25	10 $\mu$ F, 25 V Chip Capacitors	C5750X7R1E106KT	TDK
C20	0.8 pF Chip Capacitor	ATC100B0R8BT500XT	ATC
C21, C26	470 $\mu$ F, 63 V Electrolytic Capacitors	477KXM063M	Illinois Capacitor
R1	2K $\Omega$ , 1/4 W Chip Resistor	CRCW12062K00FKEA	Vishay
R2	4.3 $\Omega$ , 1/4 W Chip Resistor	CRCW12064R30FKEA	Vishay
PCB	0.030", $\epsilon_r = 3.5$	RF-35	Taconic

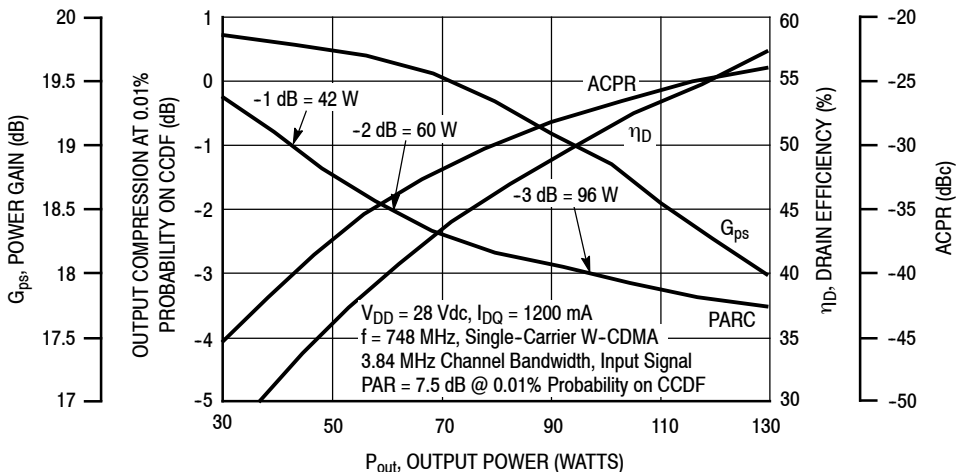
### TYPICAL CHARACTERISTICS



**Figure 2. Output Peak-to-Average Ratio Compression (PARC) Broadband Performance @ P<sub>out</sub> = 50 Watts Avg.**

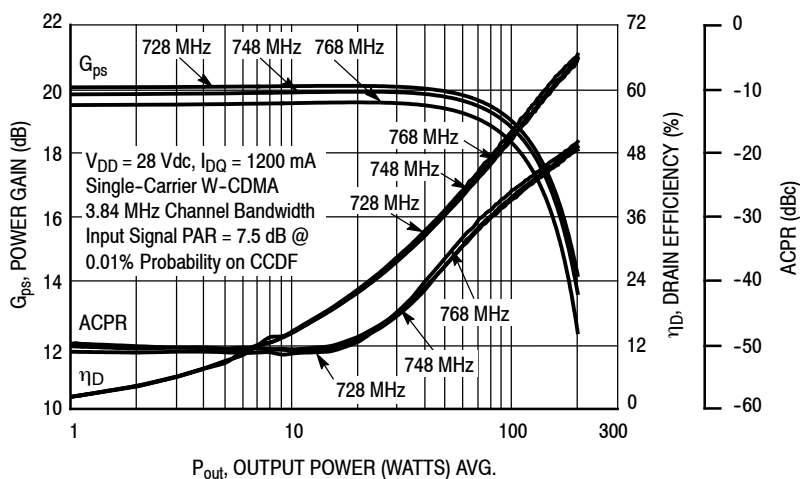


**Figure 3. Intermodulation Distortion Products versus Two-Tone Spacing**

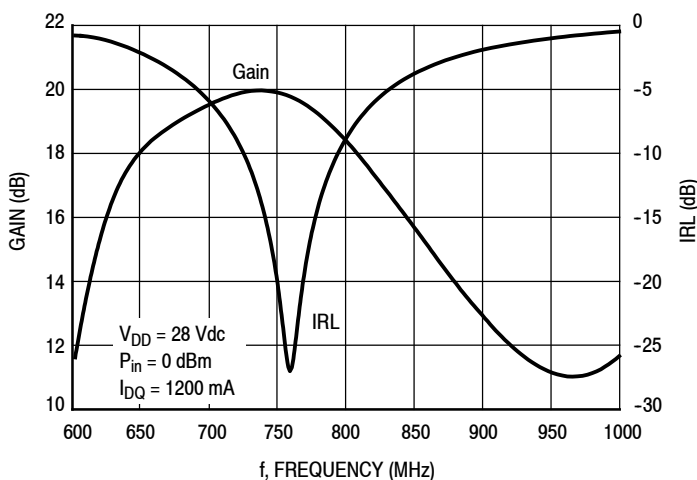


**Figure 4. Output Peak-to-Average Ratio Compression (PARC) versus Output Power**

### TYPICAL CHARACTERISTICS

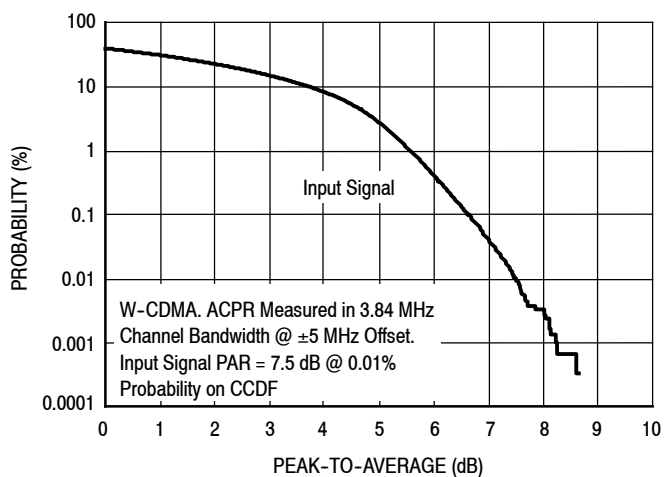


**Figure 5. Single-Carrier W-CDMA Power Gain, Drain Efficiency and ACPR versus Output Power**

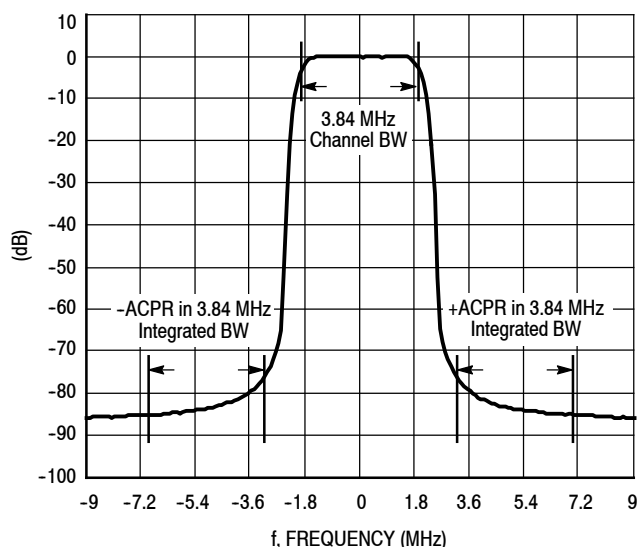


**Figure 6. Broadband Frequency Response**

### W-CDMA TEST SIGNAL



**Figure 7. CCDF W-CDMA IQ Magnitude Clipping, Single-Carrier Test Signal**



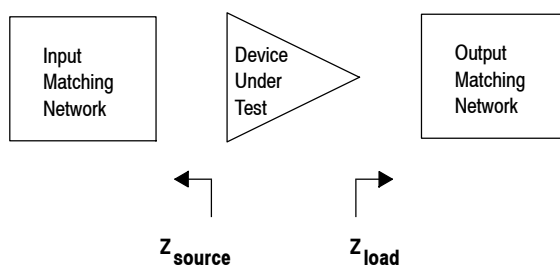
**Figure 8. Single-Carrier W-CDMA Spectrum**

$V_{DD} = 28 \text{ Vdc}$ ,  $I_{DQ} = 1200 \text{ mA}$ ,  $P_{out} = 50 \text{ W Avg.}$

f MHz	$Z_{source}$ $\Omega$	$Z_{load}$ $\Omega$
710	$0.876 - j2.237$	$1.685 - j0.887$
720	$0.910 - j2.150$	$1.659 - j0.776$
730	$0.942 - j2.080$	$1.650 - j0.683$
740	$0.970 - j2.032$	$1.660 - j0.610$
750	$0.981 - j2.013$	$1.677 - j0.563$
760	$0.961 - j2.009$	$1.688 - j0.550$
770	$0.911 - j1.996$	$1.687 - j0.551$
780	$0.843 - j1.955$	$1.660 - j0.557$
790	$0.787 - j1.881$	$1.620 + j0.548$

$Z_{source}$  = Test circuit impedance as measured from gate to ground.

$Z_{load}$  = Test circuit impedance as measured from drain to ground.



**Figure 9. Series Equivalent Source and Load Impedance**

## LOAD PULL CHARACTERISTICS

$V_{DD} = 28 \text{ Vdc}$ ,  $I_{DQ} = 1200 \text{ mA}$ , Pulsed CW, 10  $\mu\text{sec}(\text{on})$ , 10% Duty Cycle <sup>(1)</sup>

f (MHz)	P1dB		P3dB	
	Watts	dBm	Watts	dBm
600	129	51.1	178	52.5
658	219	53.4	275	54.4
698	219	53.4	282	54.5
728	229	53.6	310	54.9
748	227	53.5	303	54.8
768	214	53.3	293	54.6
805	219	53.4	275	54.4

1. Output power capability drops rapidly below 658 MHz.

NOTE: Load Pull Test Fixture Tuned for Peak P1dB Output Power @ 28 V

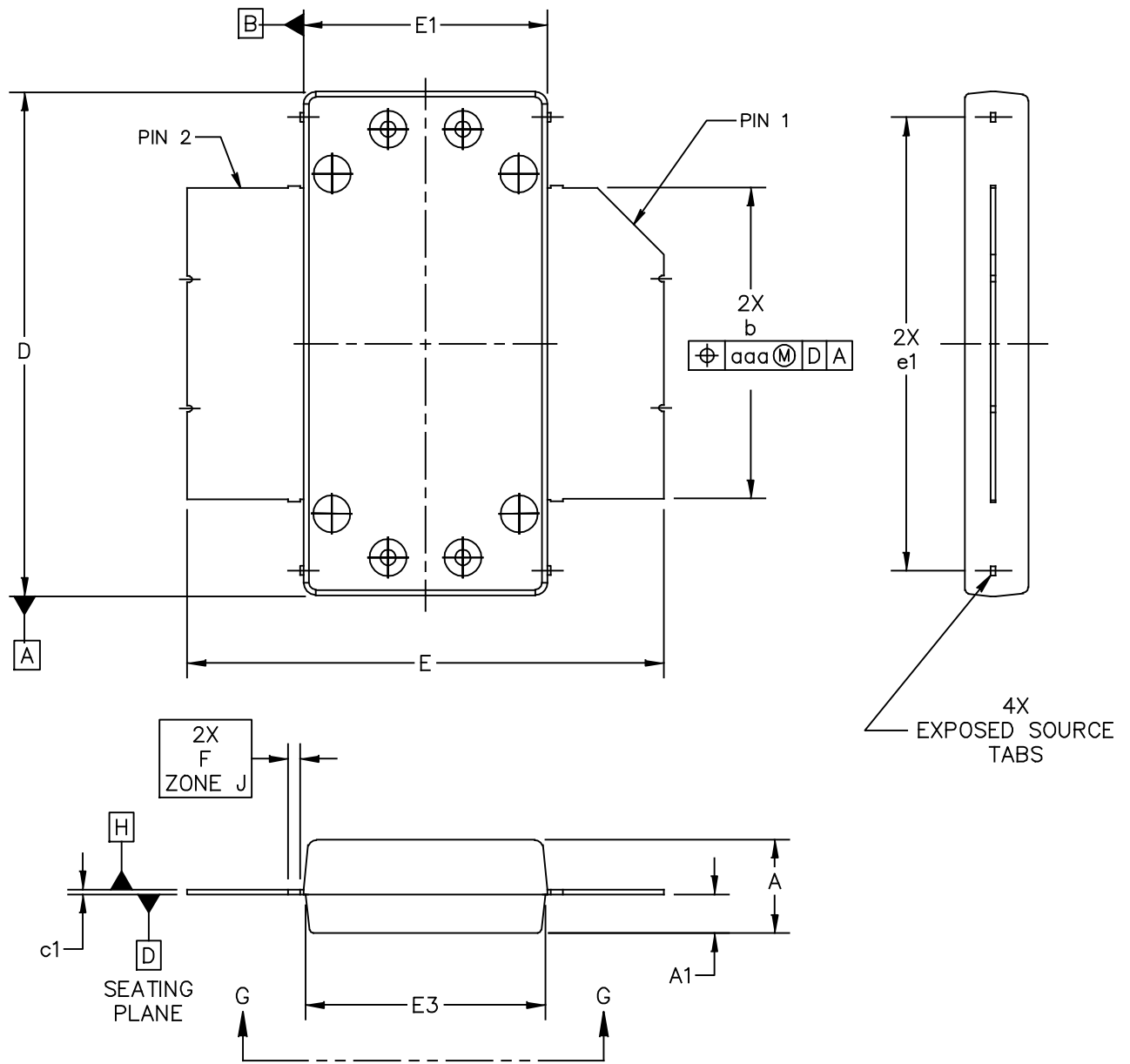
Test Impedances per Compression Level

f (MHz)		$Z_{\text{source}}$ $\Omega$	$Z_{\text{load}}$ $\Omega$
600	P1dB	2.90 - j0.40	0.70 - j2.20
658	P1dB	0.80 - j1.10	1.20 - j1.00
698	P1dB	0.70 - j1.88	1.10 - j0.97
728	P1dB	0.61 - j2.32	0.72 - j1.32
748	P1dB	0.73 - j2.60	0.81 - j1.27
768	P1dB	0.72 - j2.82	0.58 - j1.46
805	P1dB	0.90 - j3.20	1.00 - j1.20

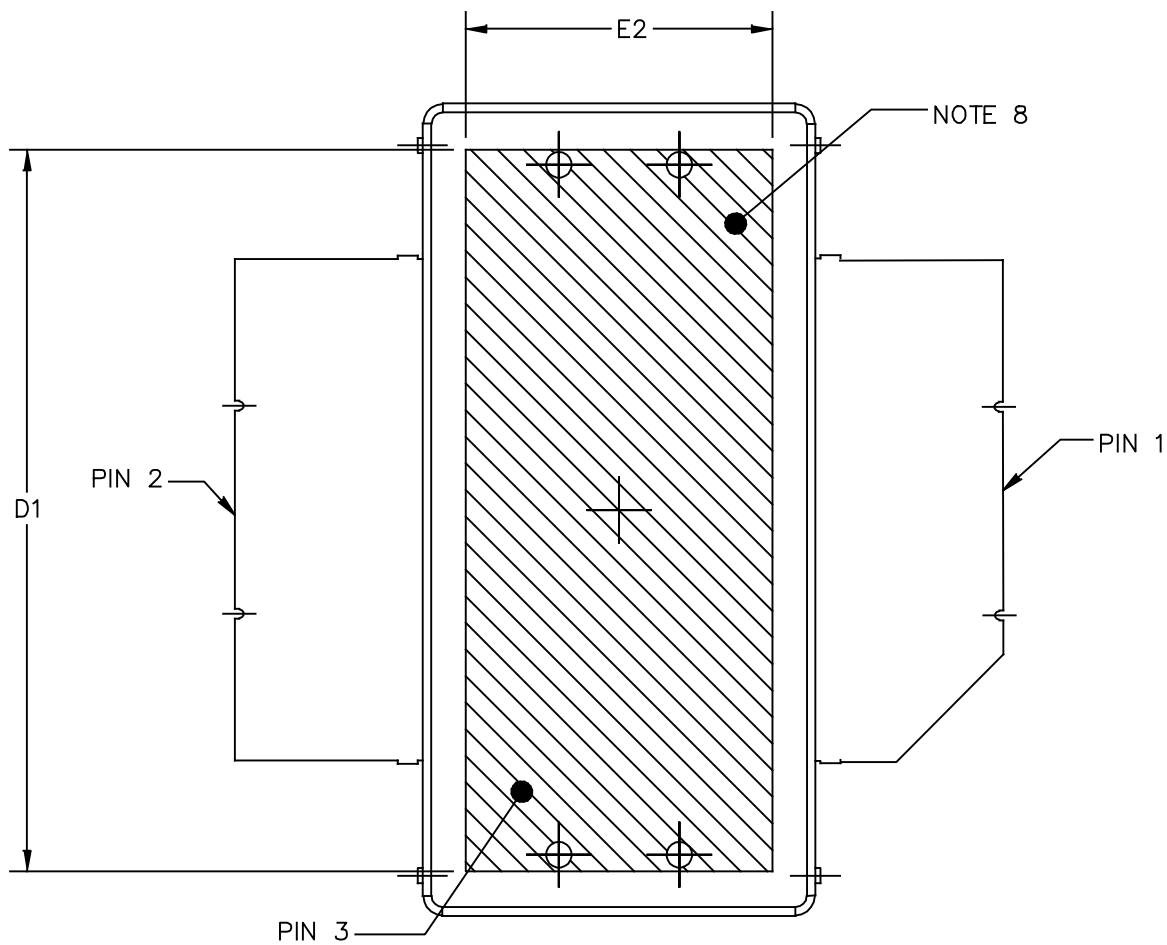
**Figure 10. Pulsed CW Output Power  
versus Input Power @ 28 V**



**PACKAGE DIMENSIONS**



© FREESCALE SEMICONDUCTOR, INC. ALL RIGHTS RESERVED.		MECHANICAL OUTLINE		PRINT VERSION NOT TO SCALE	
TITLE:  OM780-2 STRAIGHT LEAD		DOCUMENT NO: 98ASA10831D		REV: B	
		CASE NUMBER: 2021-03		22 OCT 2009	
		STANDARD: NON-JEDEC			



BOTTOM VIEW  
VIEW G-G

© FREESCALE SEMICONDUCTOR, INC. ALL RIGHTS RESERVED.	MECHANICAL OUTLINE	PRINT VERSION NOT TO SCALE	
TITLE:  OM780-2 STRAIGHT LEAD	DOCUMENT NO: 98ASA10831D	REV: B	
	CASE NUMBER: 2021-03	22 OCT 2009	
	STANDARD: NON-JEDEC		

NOTES:

1. CONTROLLING DIMENSION: INCH
2. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M-1994.
3. DATUM PLANE -H- IS LOCATED AT TOP OF LEAD AND IS COINCIDENT WITH THE LEAD WHERE THE LEAD EXITS THE PLASTIC BODY AT THE TOP OF THE PARTING LINE.
4. DIMENSIONS "D" AND "E1" DO NOT INCLUDE MOLD PROTRUSION. ALLOWABLE PROTRUSION IS .006 PER SIDE. DIMENSIONS "D AND "E1" DO INCLUDE MOLD MISMATCH AND ARE DETERMINED AT DATUM PLANE -H-.
5. DIMENSION b DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE .005 TOTAL IN EXCESS OF THE b DIMENSION AT MAXIMUM MATERIAL CONDITION.
6. DATUMS -A- AND -B- TO BE DETERMINED AT DATUM PLANE -H-.
7. DIMENSION A1 APPLIES WITHIN ZONE "J" ONLY
8. HATCHING REPRESENTS THE EXPOSED AREA OF THE HEAT SLUG. THE DIMENSIONS D1 AND E2 REPRESENT THE VALUES BETWEEN THE TWO OPPOSITE POINTS ALONG THE EDGES OF EXPOSED AREA OF HEAT SLUG.

STYLE 1:  
 PIN 1 - DRAIN  
 PIN 2 - GATE  
 PIN 3 - SOURCE

DIM	INCH		MILLIMETER		DIM	INCH		MILLIMETER	
	MIN	MAX	MIN	MAX		MIN	MAX	MIN	MAX
A	0.148	.152	3.76	3.86	b	.497	.503	12.62	12.78
A1	.059	.065	1.50	1.65	c1	.007	.011	0.18	0.28
D	.808	.812	20.52	20.62	e1	.721	.729	18.31	18.52
D1	.720	----	18.29	----					
E	.762	.770	19.36	19.56	aaa	.004		0.10	
E1	.390	.394	9.91	10.01					
E2	.306	----	7.77	----					
E3	.383	.387	9.73	9.83					
F	.025 BSC		0.635 BSC						

© FREESCALE SEMICONDUCTOR, INC. ALL RIGHTS RESERVED.		MECHANICAL OUTLINE	PRINT VERSION NOT TO SCALE
TITLE:  OM780-2 STRAIGHT LEAD		DOCUMENT NO: 98ASA10831D	REV: B
		CASE NUMBER: 2021-03	22 OCT 2009
		STANDARD: NON-JEDEC	

## PRODUCT DOCUMENTATION AND SOFTWARE

Refer to the following resources to aid your design process.

### Application Notes

- AN1907: Solder Reflow Attach Method for High Power RF Devices in Plastic Packages
- AN1955: Thermal Measurement Methodology of RF Power Amplifiers
- AN3789: Clamping of High Power RF Transistors and RFICs in Over-Molded Plastic Packages

### Engineering Bulletins

- EB212: Using Data Sheet Impedances for RF LDMOS Devices

### Software

- Electromigration MTTF Calculator
- RF High Power Model
- .s2p File

For Software, do a Part Number search at <http://www.freescale.com>, and select the “Part Number” link. Go to the Software & Tools tab on the part’s Product Summary page to download the respective tool.

## REVISION HISTORY

The following table summarizes revisions to this document.

Revision	Date	Description
0	Feb. 2010	<ul style="list-style-type: none"> <li>• Initial Release of Data Sheet</li> </ul>
1	Oct. 2010	<ul style="list-style-type: none"> <li>• Changed Human Body Model ESD rating from Class 1C to Class 2 to reflect recent ESD test results of the device, p. 2.</li> </ul>
2	Feb. 2014	<ul style="list-style-type: none"> <li>• Changed operating frequency from 728–768 MHz to 618–803 MHz due to expanded device frequency capability resulting from additional test data, p. 1</li> <li>• Typical Single-Carrier W-CDMA Performance table: added footnote 1, “This part is not recommended for Doherty applications across the 600 to 728 MHz band,” p. 1</li> <li>• Table 3, ESD Protection Characteristics: removed the word “Minimum” after the ESD class rating. ESD ratings are characterized during new product development but are not 100% tested during production. ESD ratings provided in the data sheet are intended to be used as a guideline when handling ESD sensitive devices, p. 2</li> <li>• Fig. 10, Pulsed CW Output Power versus Input Power @ 28 V: updated to reflect additional test data; added footnote 1, “Output power capability drops rapidly below 658 MHz,” p. 8</li> </ul>

### ***How to Reach Us:***

**Home Page:**  
[freescale.com](http://freescale.com)

**Web Support:**  
[freescale.com/support](http://freescale.com/support)

Information in this document is provided solely to enable system and software implementers to use Freescale products. There are no express or implied copyright licenses granted hereunder to design or fabricate any integrated circuits based on the information in this document.

Freescale reserves the right to make changes without further notice to any products herein. Freescale makes no warranty, representation, or guarantee regarding the suitability of its products for any particular purpose, nor does Freescale assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation consequential or incidental damages. "Typical" parameters that may be provided in Freescale data sheets and/or specifications can and do vary in different applications, and actual performance may vary over time. All operating parameters, including "typicals," must be validated for each customer application by customer's technical experts. Freescale does not convey any license under its patent rights nor the rights of others. Freescale sells products pursuant to standard terms and conditions of sale, which can be found at the following address: [freescale.com/SalesTermsandConditions](http://freescale.com/SalesTermsandConditions).

Freescale and the Freescale logo are trademarks of Freescale Semiconductor, Inc., Reg. U.S. Pat. & Tm. Off. All other product or service names are the property of their respective owners.

© 2010, 2014 Freescale Semiconductor, Inc.

Компания «Океан Электроники» предлагает заключение долгосрочных отношений при поставках импортных электронных компонентов на взаимовыгодных условиях!

Наши преимущества:

- Поставка оригинальных импортных электронных компонентов напрямую с производств Америки, Европы и Азии, а так же с крупнейших складов мира;
- Широкая линейка поставок активных и пассивных импортных электронных компонентов (более 30 млн. наименований);
- Поставка сложных, дефицитных, либо снятых с производства позиций;
- Оперативные сроки поставки под заказ (от 5 рабочих дней);
- Экспресс доставка в любую точку России;
- Помощь Конструкторского Отдела и консультации квалифицированных инженеров;
- Техническая поддержка проекта, помощь в подборе аналогов, поставка прототипов;
- Поставка электронных компонентов под контролем ВП;
- Система менеджмента качества сертифицирована по Международному стандарту ISO 9001;
- При необходимости вся продукция военного и аэрокосмического назначения проходит испытания и сертификацию в лаборатории (по согласованию с заказчиком);
- Поставка специализированных компонентов военного и аэрокосмического уровня качества (Xilinx, Altera, Analog Devices, Intersil, Interpoint, Microsemi, Actel, Aeroflex, Peregrine, VPT, Syfer, Eurofarad, Texas Instruments, MS Kennedy, Miteq, Cobham, E2V, MA-COM, Hittite, Mini-Circuits, General Dynamics и др.);

Компания «Океан Электроники» является официальным дистрибьютором и эксклюзивным представителем в России одного из крупнейших производителей разъемов военного и аэрокосмического назначения «**JONHON**», а так же официальным дистрибьютором и эксклюзивным представителем в России производителя высокотехнологичных и надежных решений для передачи СВЧ сигналов «**FORSTAR**».



## JONHON

«**JONHON**» (основан в 1970 г.)

Разъемы специального, военного и аэрокосмического назначения:

(Применяются в военной, авиационной, аэрокосмической, морской, железнодорожной, горно- и нефтедобывающей отраслях промышленности)

«**FORSTAR**» (основан в 1998 г.)

ВЧ соединители, коаксиальные кабели, кабельные сборки и микроволновые компоненты:

(Применяются в телекоммуникациях гражданского и специального назначения, в средствах связи, РЛС, а так же военной, авиационной и аэрокосмической отраслях промышленности).



Телефон: 8 (812) 309-75-97 (многоканальный)

Факс: 8 (812) 320-03-32

Электронная почта: [ocean@oceanchips.ru](mailto:ocean@oceanchips.ru)

Web: <http://oceanchips.ru/>

Адрес: 198099, г. Санкт-Петербург, ул. Калинина, д. 2, корп. 4, лит. А